


<b>Search Notes</b>  	<b>Application/Control No.</b>  10522916	<b>Applicant(s)/Patent Under Reexamination</b>  TANAKA ET AL.
	<b>Examiner</b>  Lamb, Christopher R	<b>Art Unit</b>  2627

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
Consulted SPE Wayne Young regarding allowable subject matter	11/15/06	CRL
Updated EAST Search	11/15/06	CRL
Consulted SPE Wayne Young regarding allowable subject matter	3/6/07	CRL
Updated EAST Search	3/7/07	CRL

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
	See EAST Search	3/27/07	CRL